

**Form PTO-1449 (modified)**  
**INFORMATION DISCLOSURE CITATION**

 Atty. Docket No.  
 8398-20

Serial No.

 Applicant:  
 Beaucoup et al.

 Filing Date  
 10 January 2002

Group


**U.S. Patent Documents**

Examiner Initial	Document Number	Date	Name	Class	Subclass
<i>CPA</i>	5,295,225	03/94	Kane et al.	395	2.35
<i>CPA</i>	5,617,472	04/97	Yoshida et al.	379	390

**Foreign Patent Documents**

Examiner Initial	Document Number	Date	Country	Name	Class	Subclass
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**Non-Patent Documents**
**Other Documents (including Author, Title, Source, Date, Pertinent Pages)**

Examiner

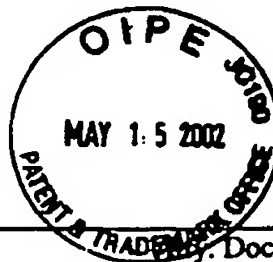
*C. Paul Harper*

Date Considered

*12/22/04*

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10/044,800

Applicant:  
Franck Beaucoup and Michael Tetelbaum

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Filing Date  
January 10, 2002

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2644

**Foreign Patent Documents**

Examiner Initial	Document Number	Date	Country	Name	Class	Subclass
<u>CPA</u>	2,309,525	11/28/2000	Canada	Mitel Corporation	G10L 11/02	H04L 12/56

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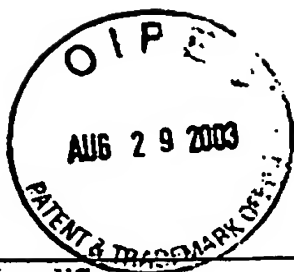
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2655

Examiner To, Doris Ha

Foreign Patent Documents

Examiner Initial	Document Number	Date	Country	Name	Class/Subclass
<u>EPA</u>	2000305579A	11/02/2000	Japan	Matsushita	G10L11/02; G10L21/02

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